

Replaces DS5868-4

# DIM600DDS12-A000

## Half Bridge IGBT Module

DS5868-5 October 2016 (LN33938)

## FEATURES

- 10µs Short Circuit Withstand
- Non Punch Through Silicon
- Isolated Cu Base with Al<sub>2</sub>O<sub>3</sub> Substrates
- Lead Free construction

## **APPLICATIONS**

- High Reliability Inverters
- Motor Controllers

The Powerline range of high power modules includes half bridge, chopper, dual, single and bi-directional switch configurations covering voltages from 600V to 3300V and currents up to 2400A.

The DIM600DDS12-A000 is a dual switch 1200V, nchannel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) plus 10µs short circuit withstand. This device is optimised for traction drives and other applications requiring high thermal cycling capability.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise grounded heat sinks for safety.

## **ORDERING INFORMATION**

Order As:

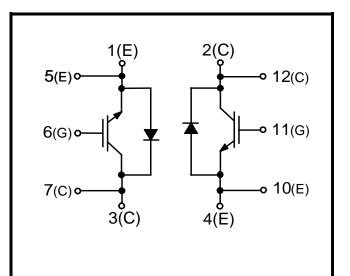
## DIM600DDS12-A000

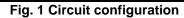
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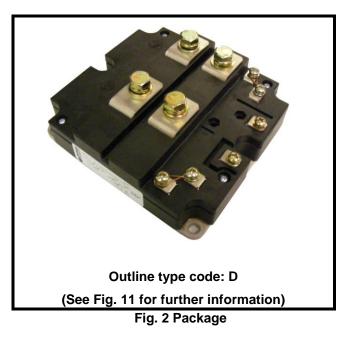
## **KEY PARAMETERS**

$V_{CES}$		1200V
V <sub>CE(sat)</sub>	* (typ)	2.2 V
l <sub>c</sub> `́	(max)	600A
I <sub>С(РК)</sub>	(max)	1200A

\* Measured at the power busbars, not the auxiliary terminals







## **ABSOLUTE MAXIMUM RATINGS**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
V <sub>GES</sub>	Gate-emitter voltage		±20	V
I <sub>C</sub>	Continuous collector current	$T_{case} = 85^{\circ}C$	600	А
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 115°C	1200	А
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	5208	W
l <sup>2</sup> t	Diode I <sup>2</sup> t value	$V_{R} = 0, t_{p} = 10ms, T_{j} = 125^{\circ}C$	100	kA <sup>2</sup> s
V <sub>isol</sub>	Isolation voltage – per module	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V

## THERMAL AND MECHANICAL RATINGS

Internal insulation material:	$AI_2O_3$
Baseplate material:	Cu
Creepage distance:	20mm
Clearance:	10mm
CTI (Comparative Tracking Index):	>600

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Units
R <sub>th(j-c)</sub>	Thermal resistance – transistor (per switch)	Continuous dissipation - junction to case	-	-	24	°C/kW
R <sub>th(j-c)</sub>	Thermal resistance – diode (per switch)	Continuous dissipation - junction to case	-	-	40	°C/kW
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink (per module)	Mounting torque 5Nm (with mounting grease)	-	-	8	°C/kW
Tj	Junction temperature	Transistor	-	-	150	°C
		Diode	-	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	-	125	°C
		Mounting – M6	-	-	5	Nm
	Screw torque	Electrical connections – M4	-	-	2	Nm
		Electrical connections – M8	-	-	10	Nm

## **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
		$V_{GE} = 0V, V_{CE} = V_{CES}$			1	mA
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V, V_{CE} = V_{CES}, T_{case} = 125^{\circ}C$			18	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$			3	μA
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_{C}$ = 20mA, $V_{GE}$ = $V_{CE}$	4.5	5.5	6.5	V
M	Collector-emitter	$V_{GE} = 15V, I_{C} = 600A$		2.2	2.8	V
V <sub>CE(sat)</sub>	saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 600A, T <sub>j</sub> = 125°C		2.6	3.2	V
١ <sub>F</sub>	Diode forward current	DC			600	А
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms			1200	А
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 600A		2.1	2.4	V
		I <sub>F</sub> = 600A, T <sub>j</sub> = 125°C		2.1	2.4	V
C <sub>ies</sub>	Input capacitance	$V_{CE} = 25V, V_{GE} = 0V, f = 1MHz$		70		nF
Qg	Gate charge	±15V		6		μC
C <sub>res</sub>	Reverse transfer capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz				nF
L <sub>M</sub>	Module inductance – per switch			20		nH
R <sub>INT</sub>	Internal transistor resistance – per switch			270		μΩ
SC <sub>Data</sub>	Short circuit current, I <sub>SC</sub>	$T_j = 125^{\circ}C, V_{CC} = 900V$ $t_p \le 10\mu s, V_{GE} \le 15V$ $V_{CE (max)} = V_{CES} - L^* x dI/dt$ IEC 60747-9		3400		A

#### Note:

L is the circuit inductance +  $L_M$ 

## **ELECTRICAL CHARACTERISTICS**

### T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time			920		ns
t <sub>f</sub>	Fall time	I <sub>C</sub> = 600A V <sub>GF</sub> = ±15V		140		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{CE} = 600V$		100		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$		390		ns
t <sub>r</sub>	Rise time	$R_{G(OFF)} = 2.7\Omega$ $L_{S} \sim 120 \text{nH}$		180		ns
E <sub>ON</sub>	Turn-on energy loss			55		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 600A		100		μC
I <sub>rr</sub>	Diode reverse recovery current	$V_{CE} = 600V$		370		А
E <sub>rec</sub>	Diode reverse recovery energy	dI <sub>F</sub> /dt = 3600A/µs		50		mJ

### T<sub>case</sub> = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min	Тур.	Max	Units
t <sub>d(off)</sub>	Turn-off delay time			1000		ns
t <sub>f</sub>	Fall time	$I_{\rm C} = 600 \text{A}$ $V_{\rm GF} = \pm 15 \text{V}$		160		ns
E <sub>OFF</sub>	Turn-off energy loss	$V_{GE} = \pm 13V$ $V_{CE} = 600V$		125		mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = 2.7\Omega$		460		ns
t <sub>r</sub>	Rise time	$R_{G(OFF)} = 2.7\Omega$ $L_{S} \sim 120 \text{nH}$		180		ns
E <sub>ON</sub>	Turn-on energy loss	25 120111		65		mJ
Q <sub>rr</sub>	Diode reverse recovery charge	I <sub>F</sub> = 600A		200		μC
I <sub>rr</sub>	Diode reverse recovery current	$V_{CE} = 600V$		480		А
E <sub>rec</sub>	Diode reverse recovery energy	dI <sub>F</sub> /dt = 3600A/µs		100		mJ

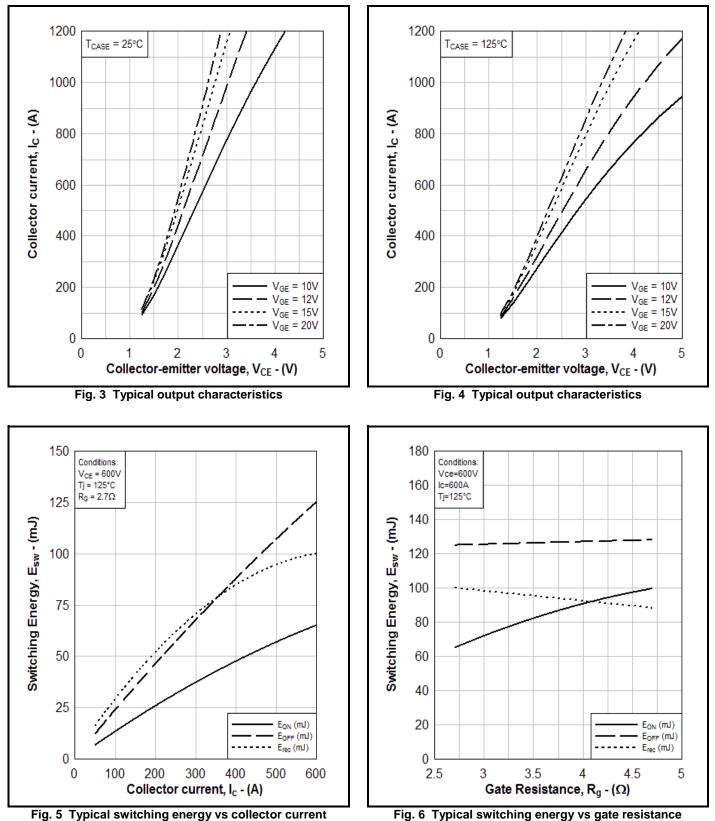


Fig. 6 Typical switching energy vs gate resistance

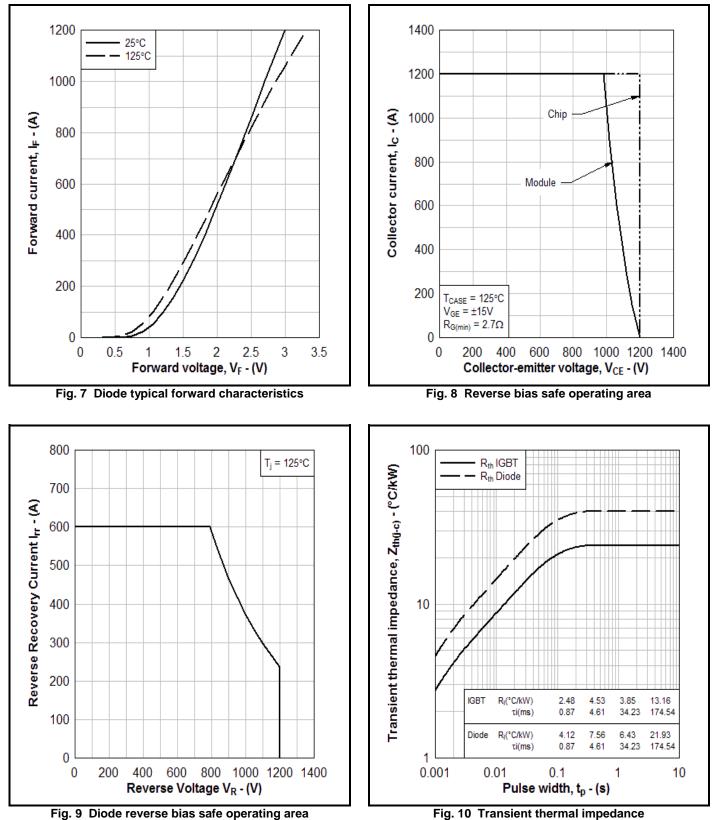
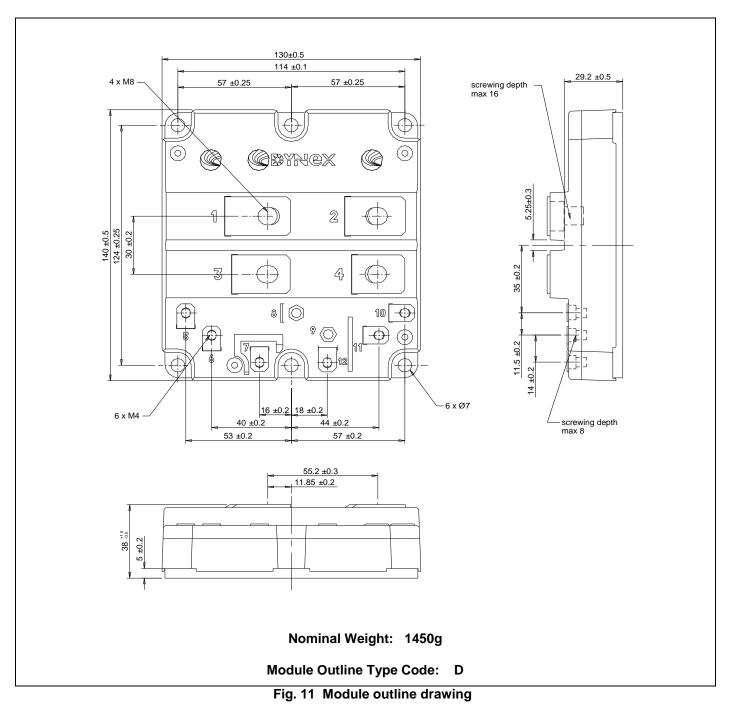


Fig. 10 Transient thermal impedance

#### PACKAGE DETAILS

For further package information, please visit our website or contact Customer Services. All dimensions in mm, unless stated otherwise. **DO NOT SCALE.** 



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